

PHP/PHB/PHD14NQ20T

TrenchMOS™ standard level FET

Rev. 03 — 11 March 2002

Product data

1. Product profile

1.1 Description

N-channel enhancement mode field-effect transistor in a plastic package using TrenchMOS™ technology.

Product availability:

PHP14NQ20T in SOT78 (TO-220AB)

PHB14NQ20T in SOT404 (D²-PAK)

PHD14NQ20T in SOT428 (D-PAK).

1.2 Features

- Low on-state resistance
- Fast switching

1.3 Applications

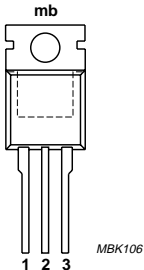
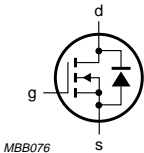
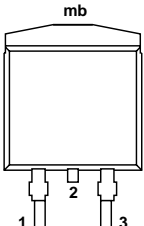
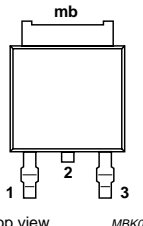
- DC to DC converters
- General purpose switching

1.4 Quick reference data

- $V_{DS} = 200\text{ V}$
- $I_D = 14\text{ A}$
- $R_{DSon} \leq 230\text{ m}\Omega$
- $P_D = 125\text{ W}$

2. Pinning information

Table 1: Pinning - SOT78, SOT404, SOT428, simplified outline and symbol

Pin	Description	Simplified outline	Symbol
1	gate (g)	 <p style="text-align: center;">MBK106</p>	 <p style="text-align: center;">MBB076</p>
2	drain (d) [1]		
3	source (s)		
mb	mounting base, connected to drain (d)	 <p style="text-align: center;">MBK116</p>	
		 <p style="text-align: center;">Top view MBK091</p>	
		SOT78 (TO-220AB) SOT404 (D²-PAK) SOT428 (D-PAK)	

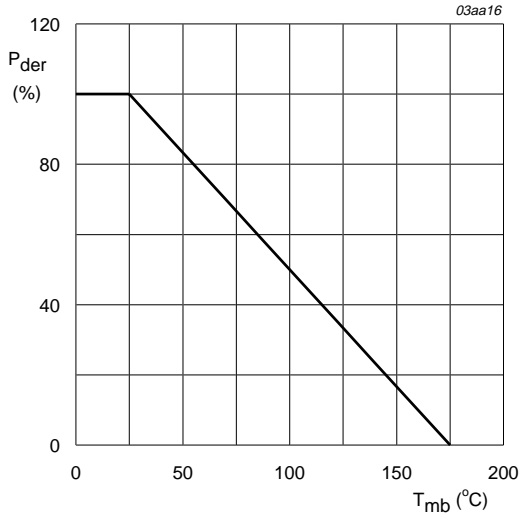
[1] It is not possible to make connection to pin 2 of the SOT404 or SOT428 packages.

3. Limiting values

Table 2: Limiting values

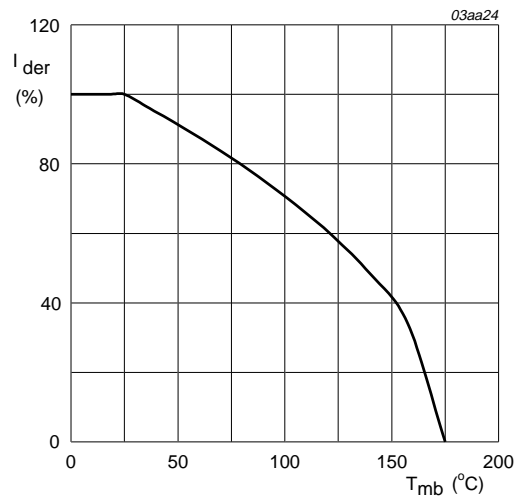
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage (DC)	$T_j = 25$ to 175 °C	-	200	V
V_{DGR}	drain-gate voltage (DC)	$T_j = 25$ to 175 °C; $R_{GS} = 20$ k Ω	-	200	V
V_{GS}	gate-source voltage		-	± 20	V
I_D	drain current (DC)	$V_{GS} = 10$ V; Figure 2 and 3 $T_{mb} = 25$ °C $T_{mb} = 100$ °C	-	14 10	A A
I_{DM}	peak drain current	$T_{mb} = 25$ °C; pulsed; $t_p \leq 10$ μ s; Figure 3	-	56	A
P_{tot}	total power dissipation	$T_{mb} = 25$ °C; Figure 1	-	125	W
T_{stg}	storage temperature		-55	+175	°C
T_j	operating junction temperature		-55	+175	°C
Source-drain diode					
I_S	source (diode forward) current (DC)	$T_{mb} = 25$ °C	-	14	A
I_{SM}	peak source (diode forward) current	$T_{mb} = 25$ °C; pulsed; $t_p \leq 10$ μ s	-	56	A
Avalanche ruggedness					
$E_{DS(ALS)}$	non-repetitive avalanche energy	unclamped inductive load; $I_D = 14$ A;	-	70	mJ
$I_{DS(ALM)}$	peak non-repetitive avalanche current	$t_p = 20$ μ s; $V_{DD} \leq 25$ V; $R_{GS} = 50$ Ω ; $V_{GS} = 10$ V; starting $T_j = 25$ °C; Figure 15	-	14	A



$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$$

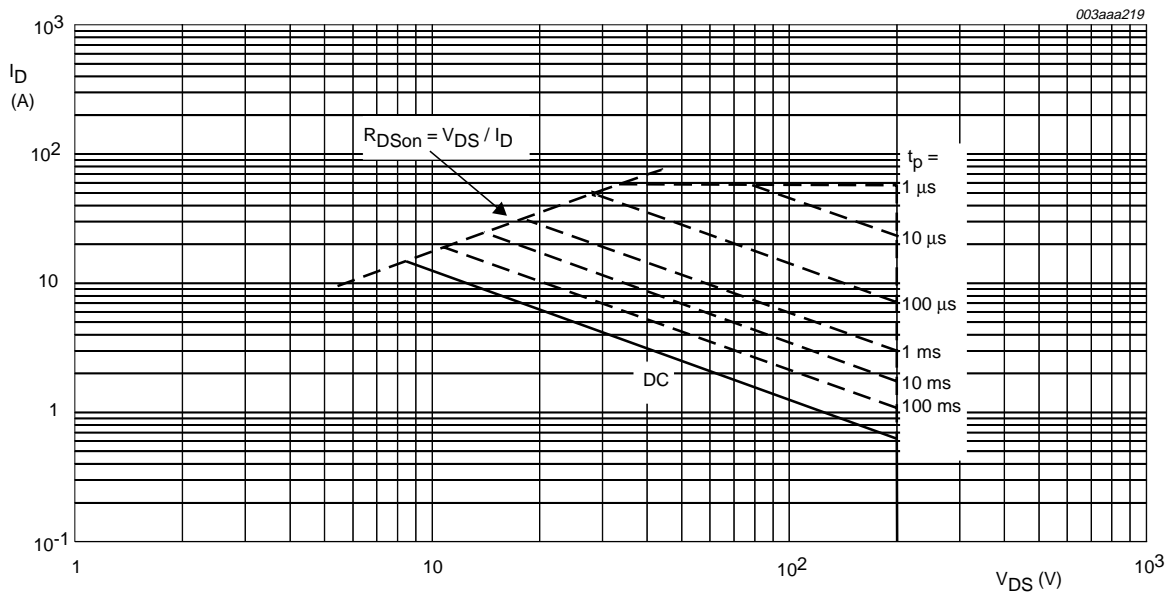
Fig 1. Normalized total power dissipation as a function of mounting base temperature.



$V_{GS} \geq 10\text{ V}$

$$I_{der} = \frac{I_D}{I_{D(25^{\circ}C)}} \times 100\%$$

Fig 2. Normalized continuous drain current as a function of mounting base temperature.



$T_{mb} = 25^{\circ}C$; I_{DM} is single pulse

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage.

4. Thermal characteristics

Table 3: Thermal characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	Figure 4	-	-	1.2	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient	vertical in still air; SOT78 package	-	60	-	K/W
		SOT404 and SOT428 packages; SOT404 minimum footprint; mounted on a PCB	-	50	-	K/W

4.1 Transient thermal impedance

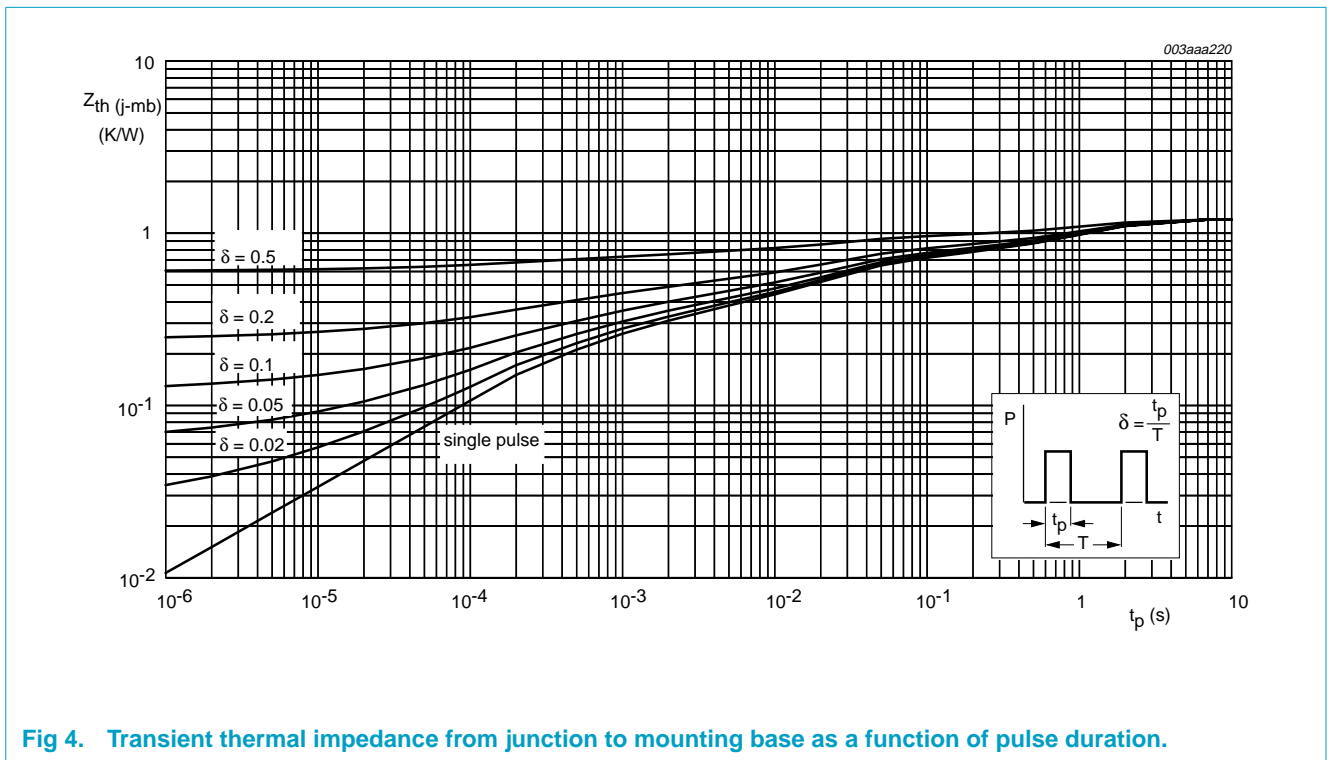


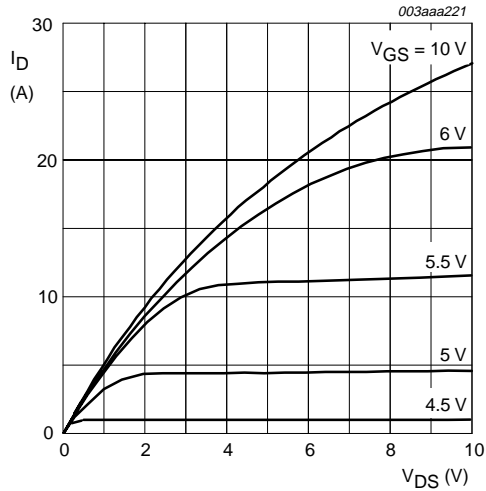
Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration.

5. Characteristics

Table 4: Characteristics

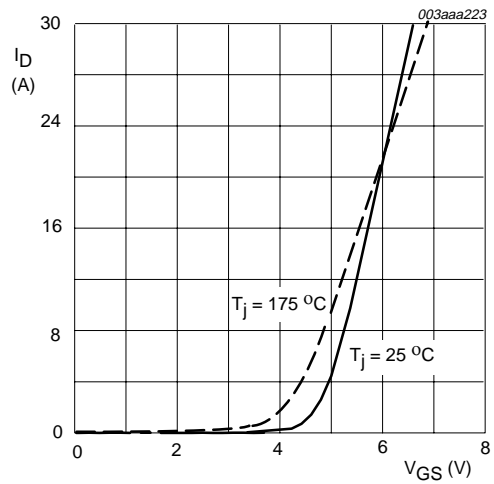
$T_j = 25\text{ °C}$ unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static characteristics						
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = 250\ \mu\text{A}$; $V_{GS} = 0\ \text{V}$ $T_j = 25\text{ °C}$	200	-	-	V
		$T_j = -55\text{ °C}$	178	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 1\ \text{mA}$; $V_{DS} = V_{GS}$; Figure 9				
		$T_j = 25\text{ °C}$	2	3	4	V
		$T_j = 175\text{ °C}$	1	-	-	V
		$T_j = -55\text{ °C}$	-	-	6	V
I_{DSS}	drain-source leakage current	$V_{DS} = 200\ \text{V}$; $V_{GS} = 0\ \text{V}$ $T_j = 25\text{ °C}$	-	0.05	10	μA
		$T_j = 175\text{ °C}$	-	-	500	μA
I_{GSS}	gate-source leakage current	$V_{GS} = \pm 10\ \text{V}$; $V_{DS} = 0\ \text{V}$	-	10	100	nA
$R_{DS(on)}$	drain-source on-state resistance	$V_{GS} = 10\ \text{V}$; $I_D = 7\ \text{A}$; Figure 7 and 8				
		$T_j = 25\text{ °C}$	-	150	230	m Ω
		$T_j = 175\text{ °C}$	-	-	633	m Ω
Dynamic characteristics						
g_{fs}	forward transconductance	$V_{DS} = 25\ \text{V}$; $I_D = 7\ \text{A}$; Figure 14	6	12.1	-	S
$Q_{g(tot)}$	total gate charge	$I_D = 14\ \text{A}$; $V_{DD} = 160\ \text{V}$;	-	38	-	nC
Q_{gs}	gate-source charge	$V_{GS} = 10\ \text{V}$; Figure 13	-	4	-	nC
Q_{gd}	gate-drain (Miller) charge		-	13.3	-	nC
C_{iss}	input capacitance	$V_{GS} = 0\ \text{V}$; $V_{DS} = 25\ \text{V}$; $f = 1\ \text{MHz}$; Figure 11	-	1500	-	pF
C_{oss}	output capacitance		-	128	-	pF
C_{rss}	reverse transfer capacitance		-	60	-	pF
$t_{d(on)}$	turn-on delay time	$V_{DD} = 30\ \text{V}$; $R_D = 10\ \Omega$;	-	25	-	ns
t_r	rise time	$V_{GS} = 10\ \text{V}$; $R_{GS} = 50\ \Omega$; $R_{gen} = 50\ \Omega$	-	40	-	ns
$t_{d(off)}$	turn-off delay time		-	83	-	ns
t_f	fall time		-	31	-	ns
Source-drain diode						
V_{SD}	source-drain (diode forward) voltage	$I_S = 14\ \text{A}$; $V_{GS} = 0\ \text{V}$; Figure 12	-	1.0	1.5	V
t_{rr}	reverse recovery time	$I_S = 14\ \text{A}$;	-	135	-	ns
Q_r	recovered charge	$di_S/dt = -100\ \text{A}/\mu\text{s}$; $V_{GS} = 0\ \text{V}$; $V_R = 30\ \text{V}$	-	690	-	nC



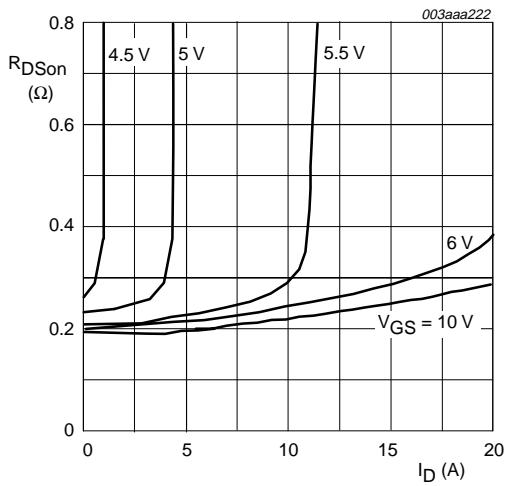
$T_j = 25\text{ }^\circ\text{C}$

Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values.



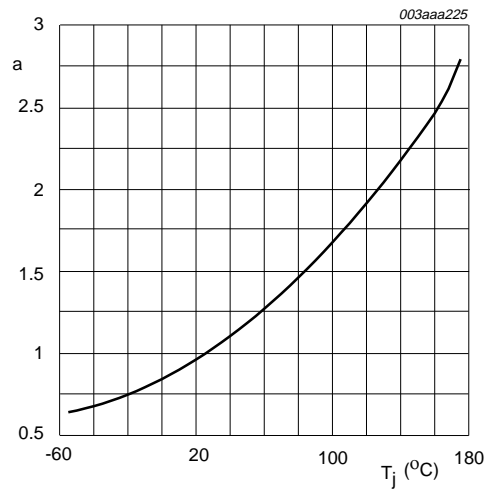
$T_j = 25\text{ }^\circ\text{C}$ and $175\text{ }^\circ\text{C}$; $V_{DS} > I_D \times R_{DSon}$

Fig 6. Transfer characteristics: drain current as a function of gate-source voltage; typical values.



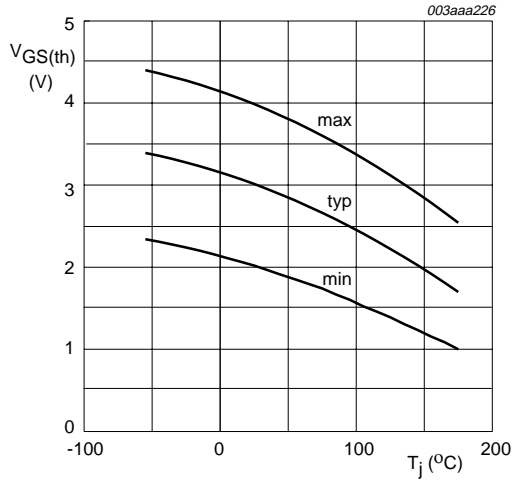
$T_j = 25\text{ }^\circ\text{C}$

Fig 7. Drain-source on-state resistance as a function of drain current; typical values.



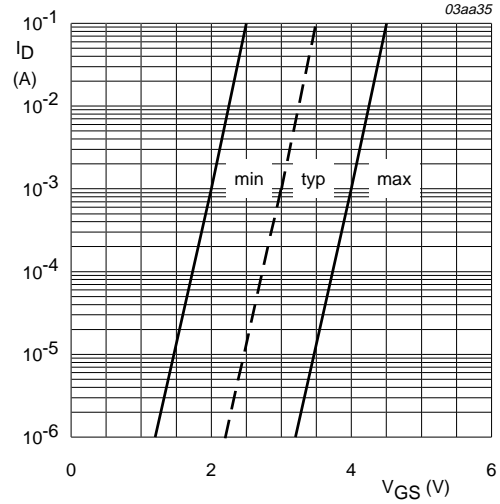
$$a = \frac{R_{DSon}}{R_{DSon}(25^\circ\text{C})}$$

Fig 8. Normalized drain source on-state resistance factor as a function of junction temperature.



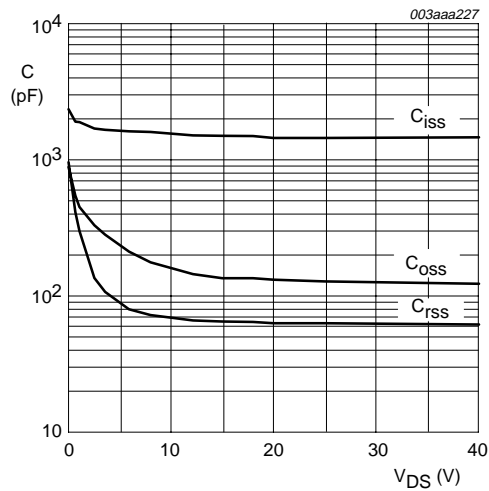
$I_D = 1 \text{ mA}; V_{DS} = V_{GS}$

Fig 9. Gate-source threshold voltage as a function of junction temperature.



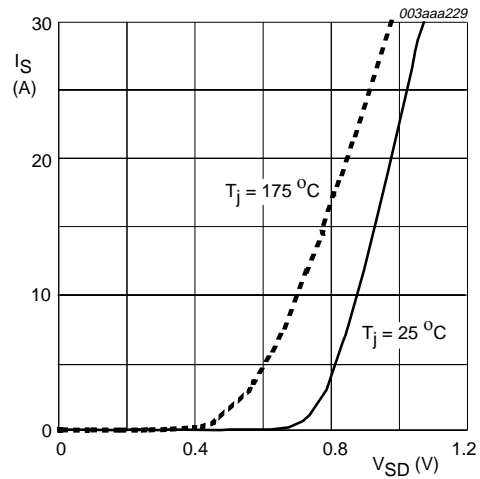
$T_j = 25 \text{ }^{\circ}C; V_{DS} = 5 \text{ V}$

Fig 10. Sub-threshold drain current as a function of gate-source voltage.



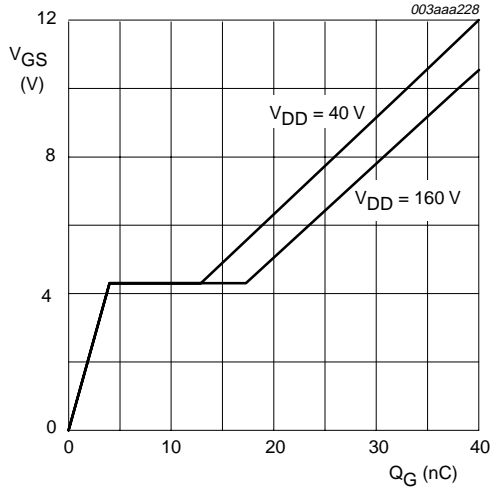
$V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$

Fig 11. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values.



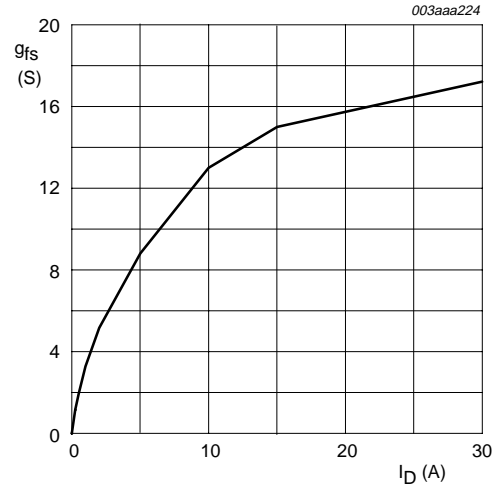
$T_j = 25 \text{ }^{\circ}C \text{ and } 175 \text{ }^{\circ}C; V_{GS} = 0 \text{ V}$

Fig 12. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values.



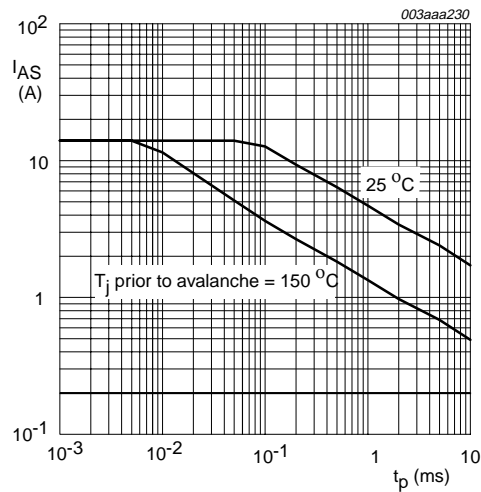
$I_D = 15\text{ A}$; $V_{DD} = 40\text{ V}$ and 160 V

Fig 13. Gate-source voltage as a function of gate charge; typical values.



$V_{DS} = 25\text{ V}$

Fig 14. Forward transconductance as a function of drain current; typical values.



Unclamped inductive load; $V_{DD} \leq 25\text{ V}$; $R_{GS} = 50\text{ }\Omega$; $V_{GS} = 10\text{ V}$; starting $T_j = 25\text{ }^\circ\text{C}$ and $150\text{ }^\circ\text{C}$

Fig 15. Non-repetitive avalanche ruggedness current as a function of pulse duration; typical values.

6. Package outline

Plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB

SOT78



Fig 16. SOT78 (TO-220AB).

Plastic single-ended surface mounted package (Philips version of D²-PAK); 3 leads (one lead cropped)

SOT404

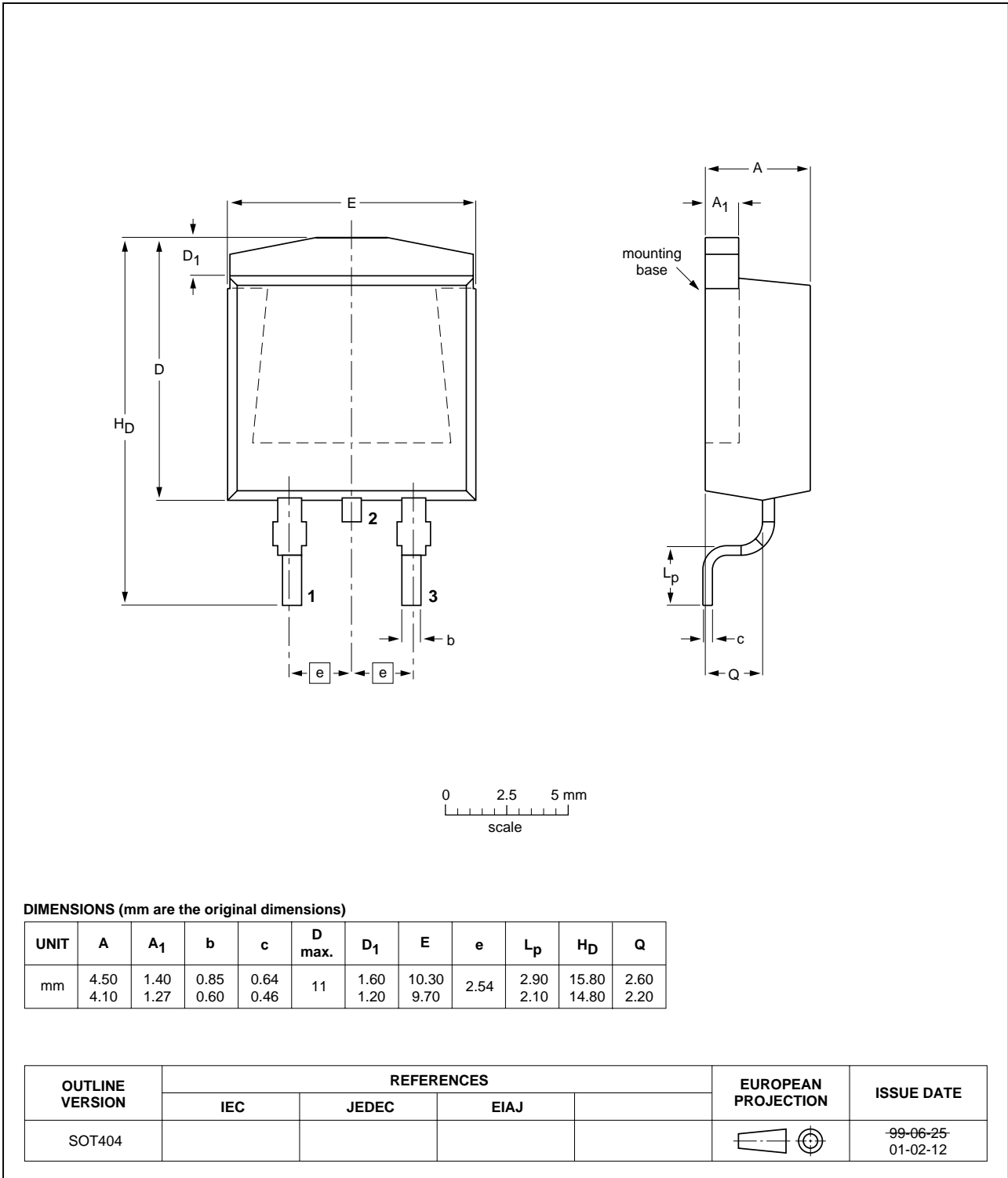


Fig 17. SOT404 (D²-PAK).

Plastic single-ended surface mounted package (Philips version of D-PAK); 3 leads (one lead cropped)

SOT428

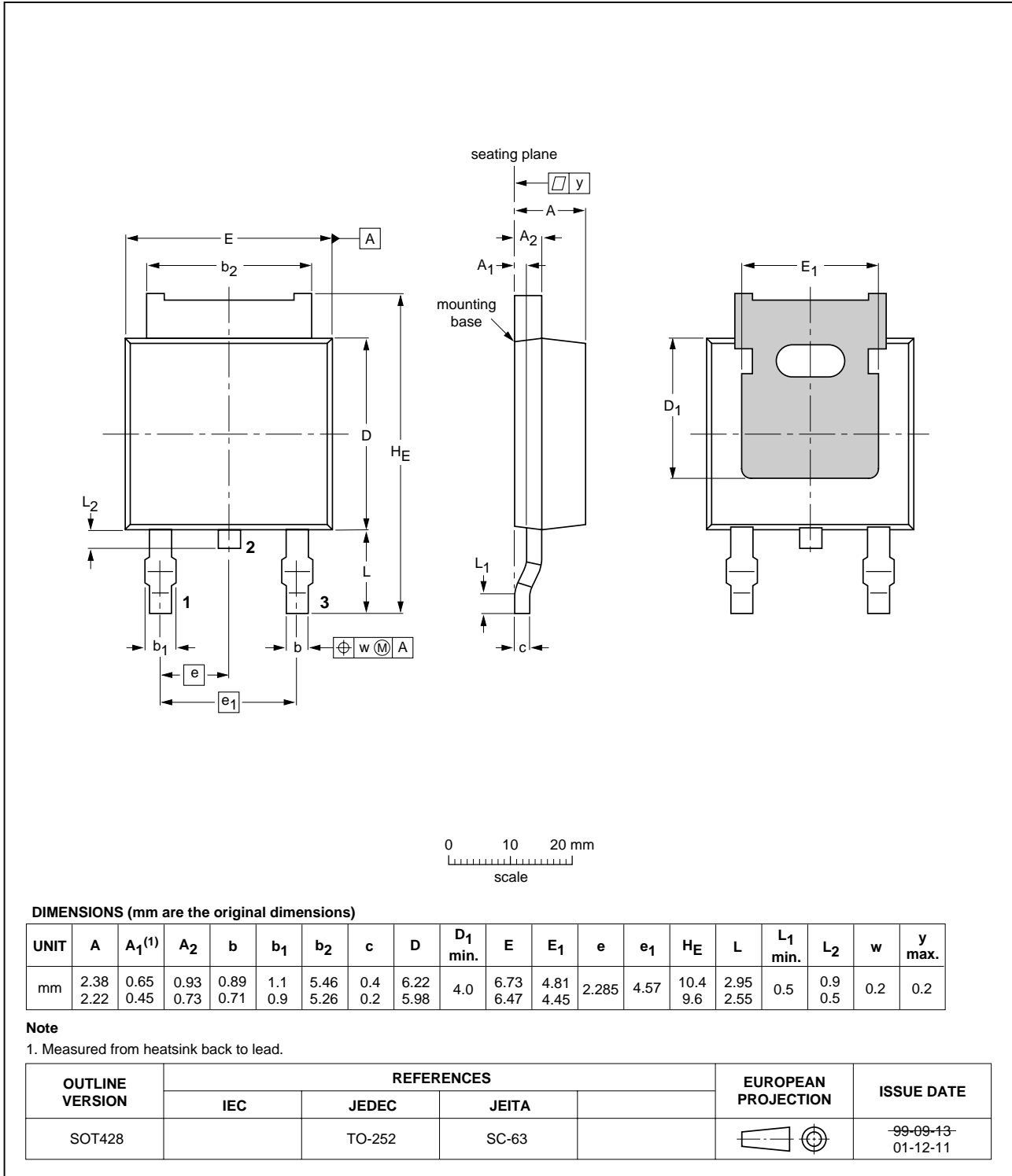


Fig 18. SOT428 (D-PAK).

7. Revision history

Table 5: Revision history

Rev	Date	CPCN	Description
03	20020311		Product data; third version. Supersedes data of 6 March 2002. Modifications: <ul style="list-style-type: none">• Correction to product title: PHD14NQ20T.
02	20020306		Product data; second version. Supersedes initial version of 1 October 1999. Modifications: <ul style="list-style-type: none">• PHD14NQ20T added.
01	19991001		Product data; initial version

8. Data sheet status

Data sheet status ^[1]	Product status ^[2]	Definition
Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
Preliminary data	Qualification	This data sheet contains data from the preliminary specification. Supplementary data will be published at a later date. Philips Semiconductors reserves the right to change the specification without notice, in order to improve the design and supply the best possible product.
Product data	Production	This data sheet contains data from the product specification. Philips Semiconductors reserves the right to make changes at any time in order to improve the design, manufacturing and supply. Changes will be communicated according to the Customer Product/Process Change Notification (CPCN) procedure SNW-SQ-650A.

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[2] The product status of the device(s) described in this data sheet may have changed since this data sheet was published. The latest information is available on the Internet at URL <http://www.semiconductors.philips.com>.

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Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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